

**Search Notes**

Application/Control No.

10/775,628

Examiner

TAN TRINH

Applicant(s)/Patent under  
Reexamination

RIIKONEN ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	502	8/23/2006	TT
	445		
	436		
	408		
	560		
370	350		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	8/23/2006	TT
HIEH VUONG	8/23/2006	TT